

Notice of References Cited

Application/Control No.

09/994,173

Applicant(s)/Patent Under
Reexamination
YOON ET AL.

Examiner

Charles Kim

Art Unit

2623

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,005,963	12-1999	Bolle et al.	382/124
	B	US-5,995,642	11-1999	Hsu et al.	382/124
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"A Nonlinear Orientation Model for Global Description of Fingerprints" by Vizcaya et al., Pattern Recognition, v. 29, no. 7, 1996, pp. 1221-1231.
	V	"A Model For Interpreting Fingerprint Topology" by Sherlock et al., Pattern Recognition, v. 26, no. 7, 1993, pp. 1047-1095.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.